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Appl	ication	/Control	No.

Applicant(s)/Patent under Reexamination

10/659,382

KIYOMIYA ET AL.

Examiner

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Brian E. Miller

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Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
PLUS Search	11/10/2004	ВЕМ
EAST Search	11/12/2004	BEM
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